

General Description

The IRFR120NTRPBF use advanced SGT MOSFET technology

to provide low RDS(ON), low gate charge, fast switching

and excellent avalanche characteristics.

This device is specially designed to get better ruggedness

and suitable to use in.



General Features

 $V_{DS} = 100V I_{D} = 12 A$

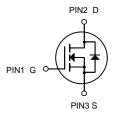
 $R_{DS(ON)}$ < 120m Ω @ V_{GS} =10V

Applications

Consumer electronic power supply

Motor control

Synchronous-rectification



N-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
IRFR120NTRPBF	TO-252-2L	12N10 XXXXX	2500

Absolute Maximum Ratings at T_j =25°C unless otherwise noted

Symbol	Parameter	Value	Unit
VDS	Drain source voltage	100	V
VGS	Gate source voltage	±20	V
ID	Continuous drain current ¹⁾	12	А
ID, pulse	Pulsed drain current ²⁾	24	А
P _D	Power dissipation ³⁾	17	W
EAS	Single pulsed avalanche energy ⁴⁾	1.2	mJ
Tstg, Tj	Operation and storage temperature	-55 to 150	℃
RθJC	Thermal resistance, junction-case	6.6	°C/W
RθJA	Thermal resistance, junction-ambient ⁵⁾	62	°C/W



N-SGT Enhancement Mode MOSFET

Electrical Characteristics Tc=25℃ unless otherwise specified

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units		
Off Charac	Off Characteristic							
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0V, I _D = 250μA	100	110	-	V		
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 100V, V _{GS} = 0V	-	-	1	μA		
I _{GSS}	Gate to Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA		
On Charac	cteristics note3							
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.0	1.8	3.0	V		
R _{DS(on)}	Static Drain-Source On-Resistance note2	V _{GS} = 10V, I _D = 3A	-	95	120	mΩ		
Dynamic (Characteristics note4		I.	ı	l .			
Ciss	Input Capacitance		-	196	-	pF		
Coss	Output Capacitance	$V_{DS} = 50V, V_{GS} = 0V,$ f = 1.0MHz	-	25.9	-	pF		
Crss	Reverse Transfer Capacitance		-	21.4	-	pF		
Qg	Total Gate Charge	V _{DS} = 50V, I _D = 3A,	-	4.3	-	nC		
Qgs	Gate-Source Charge		-	3.5	-	nC		
Q _{gd}	Gate-Drain("Miller") Charge	V _{GS} = 10V	-	3.1	-	nC		
Switching	Characteristics note4							
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 50V, I_{DS} = 3A$ $R_{G} = 2\Omega, V_{GEN} = 10V$	-	14.7	-	ns		
tr	Turn-On Rise Time		-	3.5	-	ns		
t _{d(off)}	Turn-Off Delay Time		-	20.9	-	ns		
t _f	Turn-Off Fall Time		-	2.7	-	ns		
Drain-Sou	rce Diode Characteristics and Maximum Rati	ngs	•					
ls	Maximum Continuous Drain to Source Diode Forward Current note2		-	-	4.5	Α		
Ism	Maximum Pulsed Drain to Source Diode Forward Current		-	-	12	Α		
V _{SD}	Drain to Source Diode Forward Voltage note3	V _{GS} = 0V, I _S =3A	-	-	1.3	V		
t _{rr}	Body Diode Reverse Recovery Time	\/ - 0\/ 1 - 2^	-	32.1	-	ns		
Qrr	Body Diode Reverse Recovery Time Charge	$V_{GS} = 0V, I_F = 3A,$	-	39.4	-	nC		
I _{rrm}	Peak Reverse Recovery Current	di/dt =100A/µs	-	2.1	-	Α		

Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤2%.
- 4. Guaranteed by design, not subject to production
- 5. $V_{DD}\text{=}50$ V, $R_{G}\text{=}50~\Omega,$ L=0.3 mH, starting $T_{j}\text{=}25~^{\circ}\text{C}$



Typical Performance Characteristics

Figure1: Output Characteristics

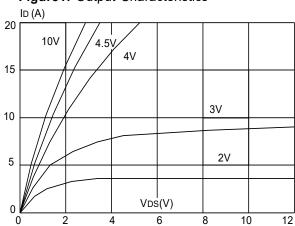


Figure 2: Typical Transfer Characteristics

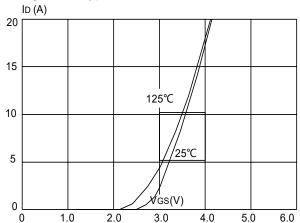


Figure 3:On-resistance vs. Drain Current

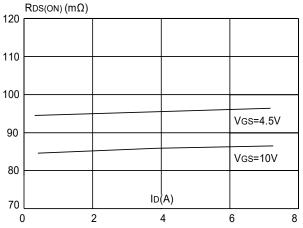


Figure 4: Body Diode Characteristics

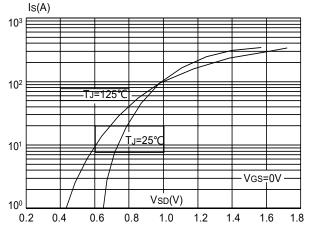
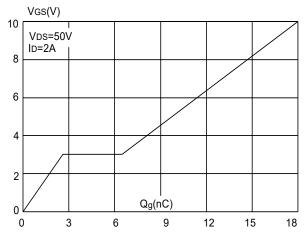
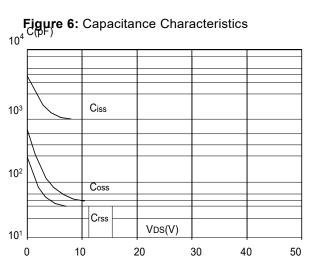


Figure 5: Gate Charge Characteristics





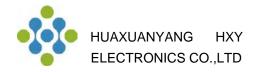


Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

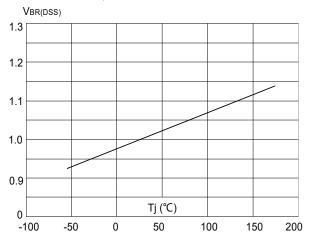


Figure 9: Maximum Safe Operating Area

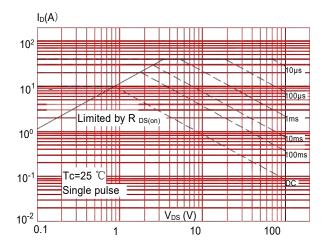


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Case

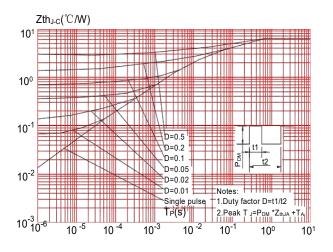


Figure 8: Normalized on Resistance vs. Junction Temperature

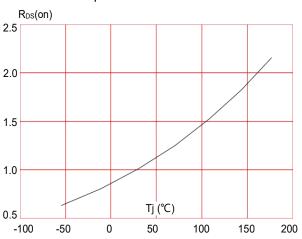
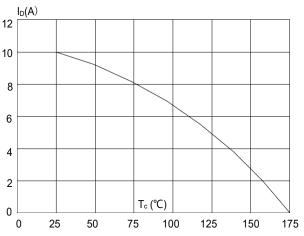
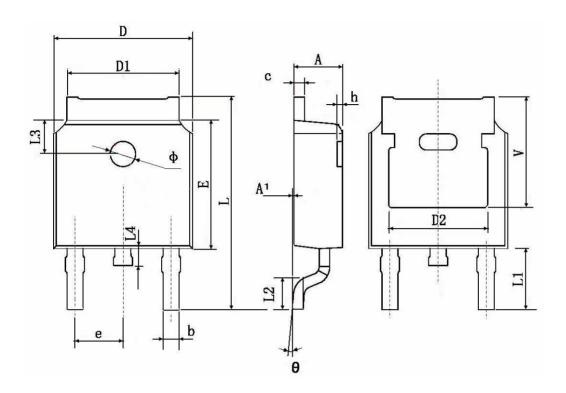


Figure 10: Maximum Continuous Drain Current vs· Case Temperature



TO-252-2L Package Information



Comple at	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
А	2.200	2.400	0.087	0.094	
A1	0.000	0.127	0.000	0.005	
b	0.660	0.860	0.026	0.034	
С	0.460	0.580	0.018	0.023	
D	6.500	6.700	0.256	0.264	
D1	5.100	5.460	0.201	0.215	
D2	0.483 TYP.		0.190 TYP.		
E	6.000	6.200	0.236	0.244	
е	2.186	2.386	0.086	0.094	
L	9.800	10.400	0.386	0.409	
L1	2.900	2.900 TYP.		0.114 TYP.	
L2	1.400	1.700	0.055	0.067	
L3	1.600	TYP.	0.063 TYP.		
L4	0.600	1.000	0.024	0.039	
Ф	1.100	1.300	0.043	0.051	
θ	0°	8°	0°	8°	
h	0.000	0.300	0.000	0.012	
V	5.350	TYP.	0.211 TYP.		



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